

Description

These N-Channel enhancement mode power field effect transistors are using trench DMOS technology. This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and with stand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency fast switching applications.

Features

- \bullet 40V,12A,R_{DS(ON).max}=12m Ω @V_{GS}=10V
- Improved dv/dt capability
- Fast switching
- Green device available

Applications

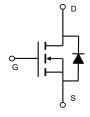
- Motor Drives
- UPS
- DC-DC Converter

Product Summary

 $\begin{array}{ll} V_{DSS} & 40V \\ R_{DS(on).max} @ V_{GS} {=} 10V & 12 m\Omega \\ I_D & 12 A \end{array}$

Pin Configuration





SOP-8

Schematic

Absolute Maximum Ratings TA= 25°C unless otherwise noted

Parameter	Symbol	Value	Unit
Drain-Source Voltage	V _{DSS}	40	V
Continuous drain current (T _A =25°C)		12	A
Continuous drain current (T _A = 100°C)	l _D	7.6	Α
Pulsed drain current ¹⁾	Ірм	48	A
Gate-Source voltage	V _{GSS}	±20	V
Power Dissipation (T _A =25°C)	P _D	2.1	W
Storage Temperature Range	T _{STG}	-55 to +150	°C
Operating Junction Temperature Range	TJ	-55 to +150	°C

Thermal Characteristics

Parameter	Symbol	Value	Unit
Thermal Resistance, Junction-to-Ambient	Reja	59.5	°C/W



Package Marking and Ordering Information

Device	Device Package	Marking
VSM12N04-S8	SOP-8	VSM12N04-S8

Electrical Characteristics T_J = 25°C unless otherwise noted

Parameter	Symbol	Test Condition	Min.	Тур.	Max.	Unit
Static characteristics	-			'		
Drain-source breakdown voltage	BV _{DSS}	V _{GS} =0 V, I _D =250uA	40			V
Gate threshold voltage	V _{GS(th)}	V _{DS} =V _{GS} , I _D =250uA	1.0		2.0	V
Drain-source leakage current	Ipss	V _{DS} =40 V, V _{GS} =0 V, T _J = 25°C			1	μA
		V _{DS} =32 V, V _{GS} =0 V, T _J = 125°C			10	μA
Gate leakage current, Forward	I _{GSSF}	V _{GS} =20 V, V _{DS} =0 V			100	nA
Gate leakage current, Reverse	I _{GSSR}	V _{GS} =-20 V, V _{DS} =0 V			-100	nA
	_	V _{GS} =10 V, I _D =12 A		9.2	12	mΩ
Drain-source on-state resistance	R _{DS(on)}	V _{GS} =4.5 V, I _D =8 A		11.8	16	mΩ
Forward transconductance	g _{fs}	V _{DS} =5 V , I _D =20A		35		S
Dynamic characteristics						
Input capacitance	C _{iss}	V 00 V V 0 V		1370		pF
Output capacitance	Coss	$V_{DS} = 20 \text{ V}, V_{GS} = 0 \text{ V},$ $V_{DS} = 1 \text{ MHz}$		158		
Reverse transfer capacitance	C _{rss}	- F = IMMZ		125		
Turn-on delay time	t _{d(on)}			14.5		
Rise time	tr			19.2		- ns
Turn-off delay time	t _{d(off)}	$V_{DD} = 20V, V_{GS} = 10V, I_D = 12 A$		61		
Fall time	t _f	-		27		
Gate resistance	Rg	V _{GS} =0V, V _{DS} =0V, F=1MHz		3.5		Ω
Gate charge characteristics					1	
Gate to source charge	Q _{gs}	V _{DS} =20V, I _D =12A, V _{GS} = 10V		7.1		
Gate to drain charge	Q _{gd}			2.9		nC
Gate charge total	Qg			27.5		
Drain-Source diode characteristic	s and Maxir	num Ratings		'	1	
Continuous Source Current	Is				12	А
Pulsed Source Current ³⁾	I _{SM}				48	А
Diode Forward Voltage	V _{SD}	V _{GS} =0V, I _S =10A, T _J =25℃			1.2	V
Reverse Recovery Time	t _{rr}	Is=12A,di/dt=100A/us, Tյ=25℃		21		ns
Reverse Recovery Charge	Qrr			7.8		nC

Notes:

^{1:} Repetitive Rating: Pulse width limited by maximum junction temperature.

^{2:} Pulse Test: Pulse Width \leq 300 μ s, Duty Cycle \leq 2%.



Electrical Characteristics Diagrams

Figure 1. Typ. Output Characteristics

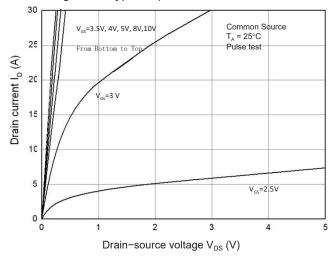


Figure 2. Transfer Characteristics

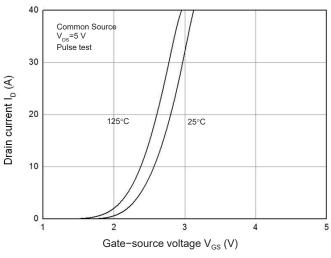


Figure 3. Capacitance Characteristics

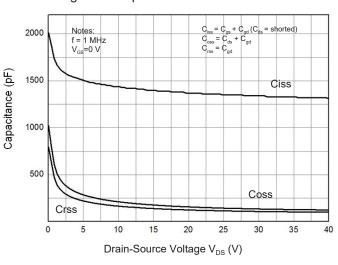


Figure 4. Gate Charge Waveform

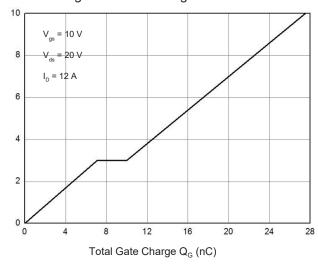


Figure 5. Body-Diode Characteristics

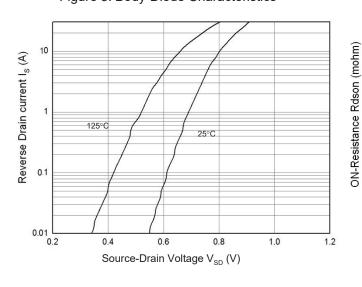
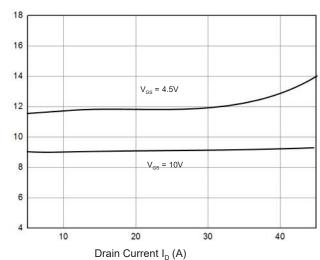
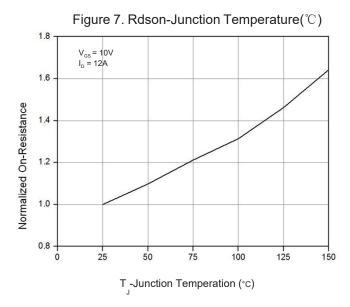


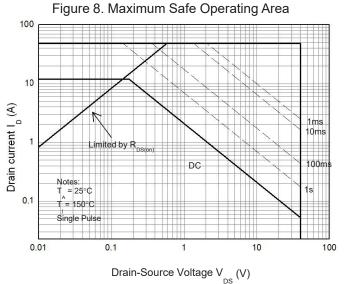
Figure 6. Rdson-Drain Current

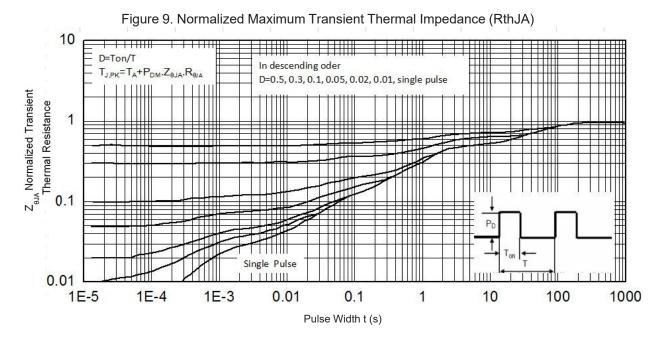


Gate-Source Voltage V_{GS} (V)





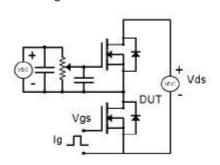






Test Circuit & Waveform

Figure 8. Gate Charge Test Circuit & Waveform



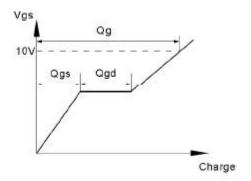


Figure 9. Resistive Switching Test Circuit & Waveforms

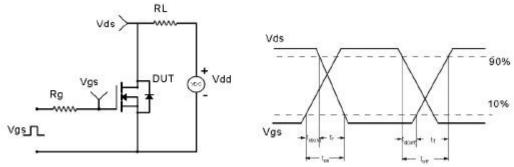


Figure 10. Unclamped Inductive Switching (UIS) Test Circuit & Waveform

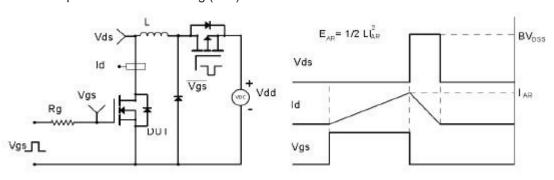


Figure 11. Diode Recovery Circuit & Waveform

